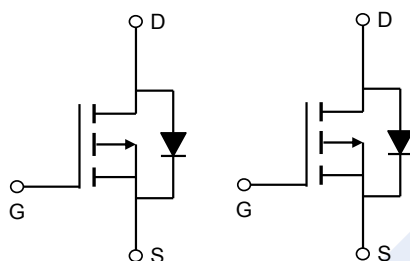
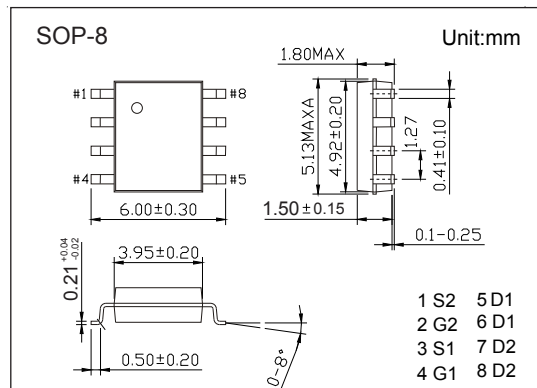


Dual P-Channel MOSFET

AO4813 (KO4813)

■ Features

- $V_{DS} (V) = -30V$
- $I_D = -7.1 A$ ($V_{GS} = -10V$)
- $R_{DS(ON)} < 25m\Omega$ ($V_{GS} = -10V$)
- $R_{DS(ON)} < 40m\Omega$ ($V_{GS} = -4.5V$)

■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter		Symbol	Rating	Unit
Drain-Source Voltage		V_{DS}	-30	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current	$T_A = 25^\circ C$	I_D	-7.1	A
	$T_A = 70^\circ C$		-5.6	
Pulsed Drain Current		I_{DM}	-40	
Avalanche Current		I_{AS}, I_{AR}	-27	
Avalanche Energy	$L=0.1mH$	E_{AS}, E_{AR}	36	mJ
Power Dissipation	$T_A = 25^\circ C$	P_D	2	W
	$T_A = 70^\circ C$		1.3	
Thermal Resistance.Junction- to-Ambient	$t \leq 10s$	R_{thJA}	62.5	$^\circ C/W$
	Steady-State		90	
Thermal Resistance.Junction- to-Lead		R_{thJL}	40	$^\circ C$
Junction Temperature		T_J	150	
Storage Temperature Range		T_{stg}	-55 to 150	

Dual P-Channel MOSFET

AO4813 (KO4813)

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V _{DSS}	I _D =-250 μA, V _{GS} =0V	-30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-30V, V _{GS} =0V			-1	μA
		V _{DS} =-30V, V _{GS} =0V, T _J =55°C			-5	
Gate-Body Leakage Current	I _{GSS}	V _{DS} =0V, V _{GS} =±20V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	-1.5		-2.5	V
Static Drain-Source On-Resistance	R _{DS(on)}	V _{GS} =-10V, I _D =-7.1A			25	mΩ
		V _{GS} =-10V, I _D =-7.1A, T _J =125°C			33	
		V _{GS} =-4.5V, I _D =-5.6A			40	
On State Drain Current	I _{D(ON)}	V _{GS} =-10V, V _{DS} =-5V	-40			A
Forward Transconductance	g _{FS}	V _{DS} =-5V, I _D =-7.1A		24		S
Input Capacitance	C _{iss}	V _{GS} =0V, V _{DS} =-15V, f=1MHz		1040	1250	pF
Output Capacitance	C _{oss}			180		
Reverse Transfer Capacitance	C _{rss}			125	175	
Gate Resistance	R _g	V _{GS} =0V, V _{DS} =0V, f=1MHz	2		6	Ω
Total Gate Charge (10V)	Q _g	V _{GS} =-10V, V _{DS} =-15V, I _D =-7.1A		19		nC
Total Gate Charge (4.5V)				9.6		
Gate Source Charge	Q _{gs}			3.6		
Gate Drain Charge	Q _{gd}			4.6		
Turn-On DelayTime	t _{d(on)}	V _{GS} =-10V, V _{DS} =-15V, R _L =2.2Ω, R _{GEN} =3Ω		10		ns
Turn-On Rise Time	t _r			5.5		
Turn-Off DelayTime	t _{d(off)}			26		
Turn-Off Fall Time	t _f			9		
Body Diode Reverse Recovery Time	t _{rr}	I _F =-7.1A, di/dt= 500A/μs		11.5		nC
Body Diode Reverse Recovery Charge	Q _{rr}			25		
Maximum Body-Diode Continuous Current	I _S				-2.5	A
Diode Forward Voltage	V _{SD}	I _S =-1A, V _{GS} =0V			-1	V

Note: The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

■ Marking

Marking	4813 KA****
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Dual P-Channel MOSFET

AO4813 (K04813)

■ Typical Characteristics

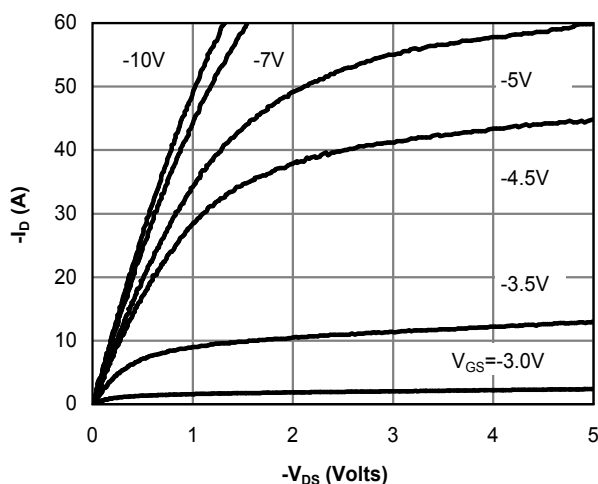


Fig 1: On-Region Characteristics (Note E)

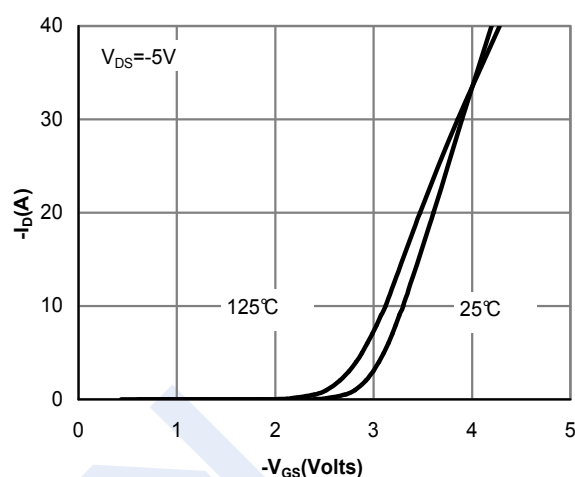


Figure 2: Transfer Characteristics (Note E)

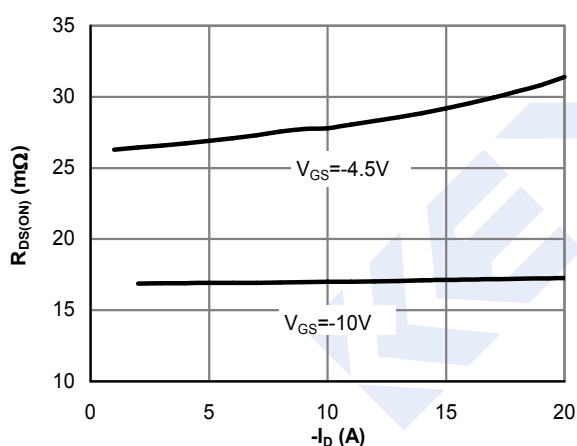


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

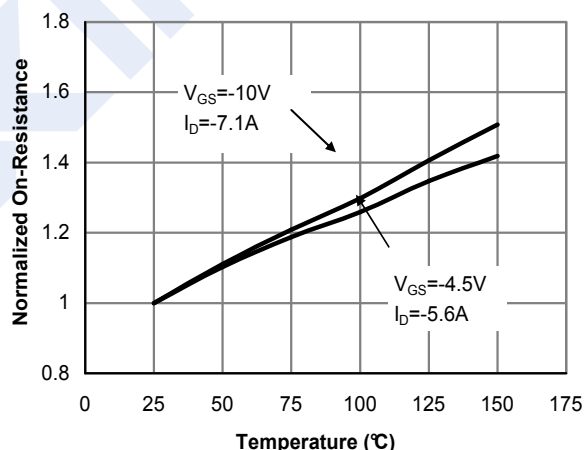


Figure 4: On-Resistance vs. Junction Temperature (Note E)

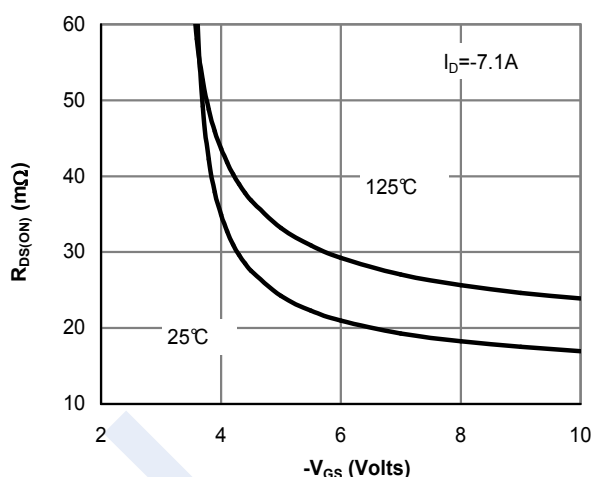


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

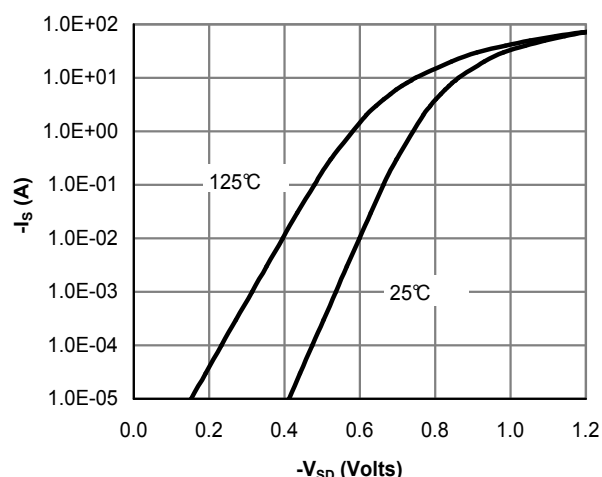


Figure 6: Body-Diode Characteristics (Note E)

Dual P-Channel MOSFET

AO4813 (KO4813)

■ Typical Characteristics

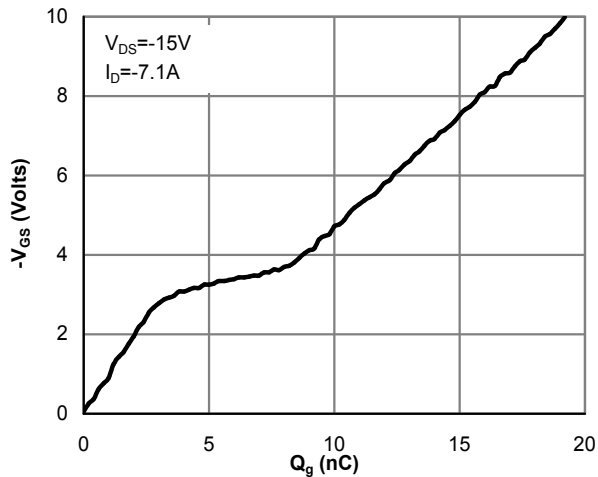


Figure 7: Gate-Charge Characteristics

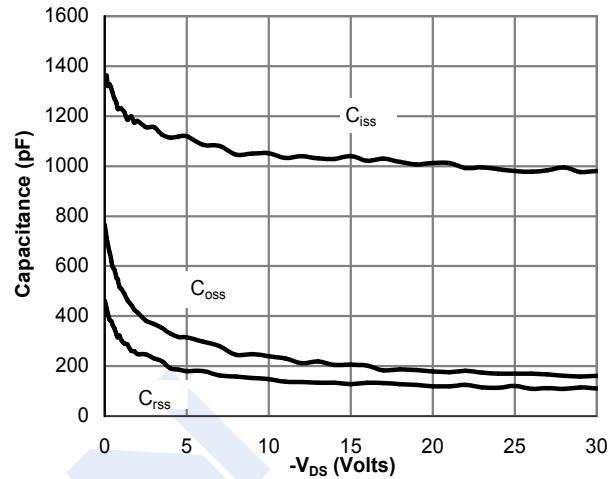


Figure 8: Capacitance Characteristics

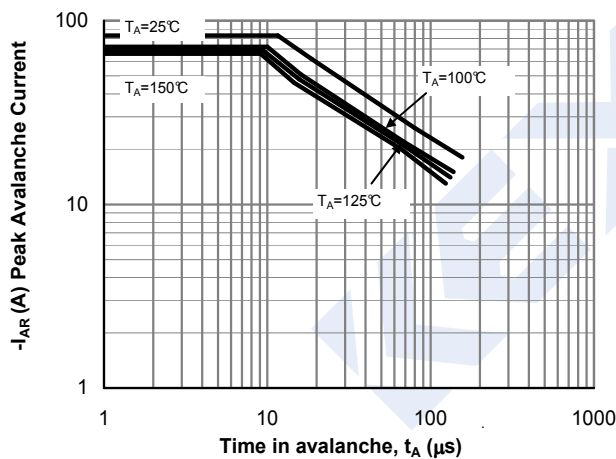


Figure 9: Single Pulse Avalanche capability (Note C)

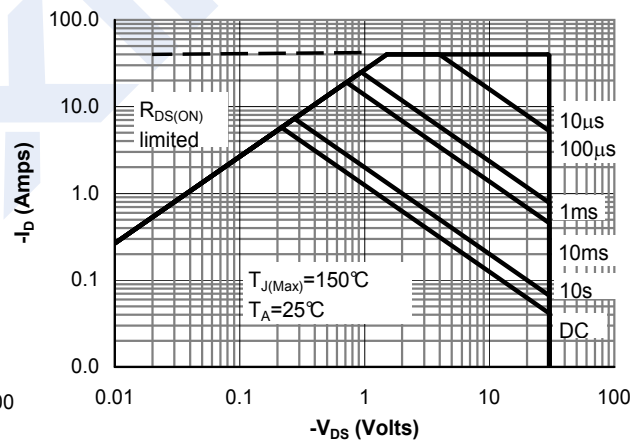


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)



Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

Dual P-Channel MOSFET

AO4813 (KO4813)

■ Typical Characteristics

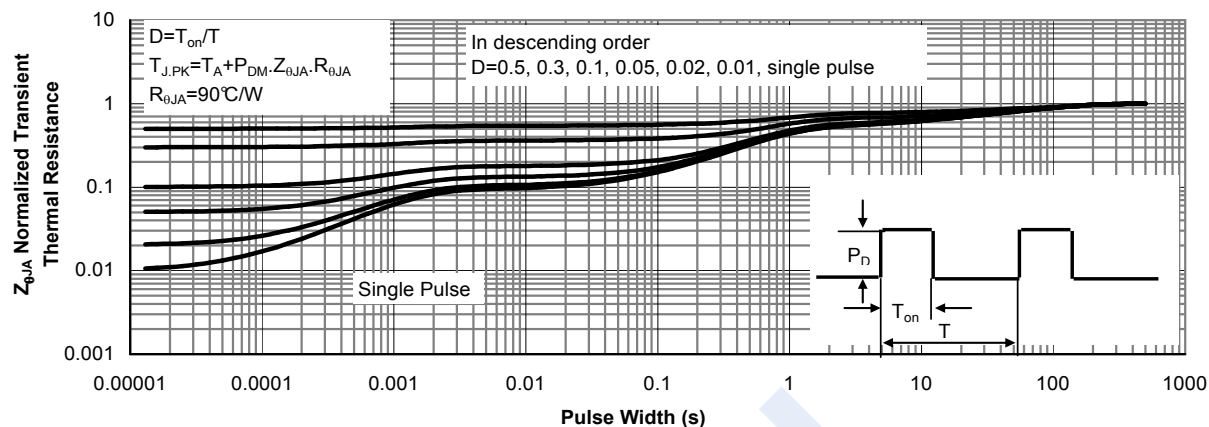


Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)